Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/674,455	KUWAHARA ET AL.	
Examiner	Art Unit	
Huy D. Nguyen	2617	

SEARCHED								
Cla	ass	Subclass	Date		Examiner			
4:	55	67.14	4/12/2006		HN			
		67.16						
		139						
		226.1						
		67.11						
		67.13						
		67.15						
		67.7						
		24						
		501						
342		165						
		174						
		442						
Updated		search	11/16/2006		HN			

INTERFERENCE SEARCHED							
Class	Subclass	Date	Examiner HN				
455	67.14	11/16/2006					
	67.16						
	67.11						

SEARCH NOTES (INCLUDING SEARCH STRATEGY)						
	DATE	EXMR				
East; Text search (USPAT, US-PGPUB, JPO, EPO, DERWENT). See search history printout.	4/12/2006	ни				
East; Text search (USPAT, US- PGPUB, JPO, EPO, DERWENT). See search history printout.	11/16/2006	НИ				
See interference search printout.	11/16/2006	НИ				